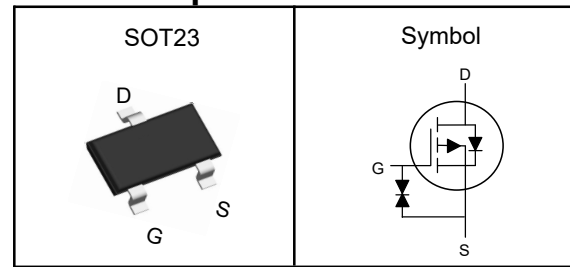


P-Channel Enhancement Mode MOSFET
Features

- Low $R_{ds(on)}$ for low conduction loss
- Reliable and Rugged
- ROHS Compliant & Halogen-Free

Applications

- Power Management in Desktop Computer
- DC/DC Converters

Pin Description


V_{DSS}	-100	V
$R_{DS(ON)-Typ}$	450	m Ω
I_D	-0.9	A

Absolute Maximum Ratings ($T_A=25^\circ\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Rating	Unit
V_{DSS}	Drain-Source Voltage	-100	V
V_{GSS}	Gate-Source Voltage	± 20	V
T_J	Maximum Junction Temperature	-55 to 150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$I_{DM}^{①}$	Pulse Drain Current Tested	-3.6	A
I_D	Continuous Drain Current	-0.9	A
P_D	Maximum Power Dissipation	$T_C=25^\circ\text{C}$ 0.9	W

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JA}^{③}$	Thermal Resistance-Junction to Ambient (Max)	145	$^\circ\text{C}/\text{W}$

Note ① : Max. current is limited by bonding wire.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C .

Note ③ : Surface Mounted on 1in^2 FR-4 board with 1oz.

**P-Channel Enhancement Mode MOSFET****Electrical Characteristics** ($T_J=25^\circ\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-100	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-80V, V_{GS}=0V$	---	---	-1	μA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1	---	-2.5	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	± 100	nA
$R_{DS(on)}$	Drain-Source On-state Resistance	$V_{GS}=-10V, I_D=-1A$	---	450	600	$m\Omega$
		$V_{GS}=-4.5V, I_D=-0.5A$	---	550	800	$m\Omega$
gfs	Forward Transconductance	$V_{DS}=-4.5V, I_D=-1A$	---	---	---	S
Dynamic Characteristics ^⑤						
C_{iss}	Input Capacitance	$V_{GS}=0V,$ $V_{DS}=-50V,$ Freq.=1MHz	---	270	---	pF
C_{oss}	Output Capacitance		---	20	---	
C_{rss}	Reverse Transfer Capacitance		---	21	---	
$T_{d(on)}$	Turn-on Delay Time	$V_{DD}=-50V, V_{GS}=-10V,$ $R_G=6\Omega, I_D=1A$	---	8.2	---	nS
T_r	Turn-on Rise Time		---	1.2	---	
$T_{d(off)}$	Turn-off Delay Time		---	21	---	
T_f	Turn-off Fall Time		---	1.8	---	
Q_g	Total Gate Charge	$V_{DS}=-50V, V_{GS}=-10V,$ $I_D=-1A$	---	6.6	---	nC
Q_{gs}	Gate-Source Charge		---	1	---	
Q_{gd}	Gate-Drain Charge		---	1.5	---	
Source-Drain Characteristics ($T_J=25^\circ\text{C}$)						
V_{SD} ^④	Diode Forward Voltage	$V_{GS}=0V, I_S=-1A, T_J=25^\circ\text{C}$	---	---	-1.2	V
t_{rr}	Reverse Recovery Time	$I_F=-1A, di/dt=100A/\mu s$	---	17	---	nS
Q_{rr}	Reverse Recovery Charge		---	12	---	nC

Note ④ : Pulse test (pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$).

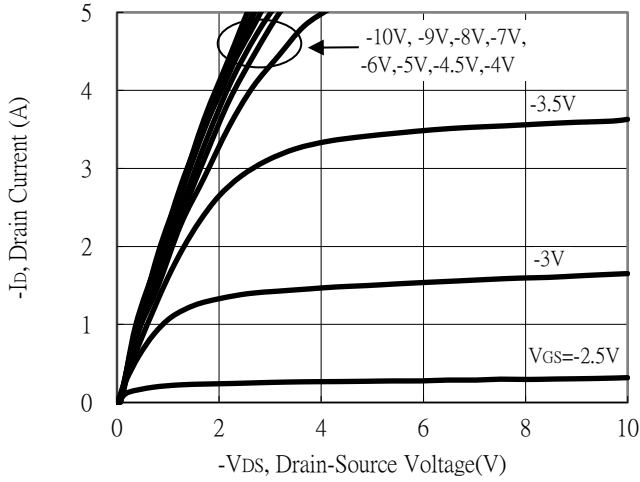
Note ⑤ : Guaranteed by design, not subject to production testing.



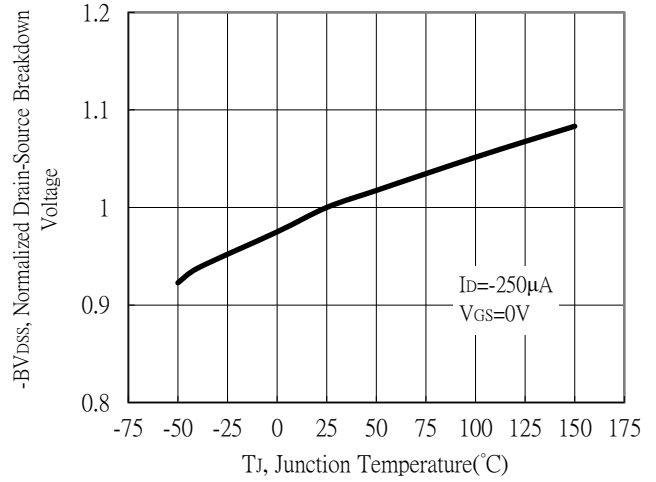
P-Channel Enhancement Mode MOSFET

Typical Characteristics

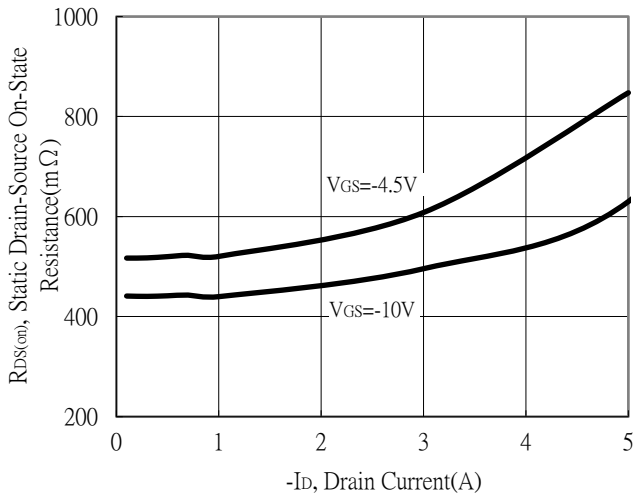
Typical Output Characteristics



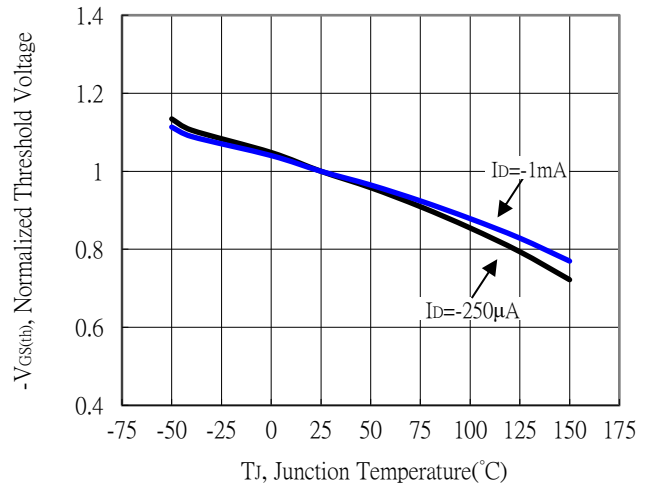
Breakdown Voltage vs Ambient Temperature



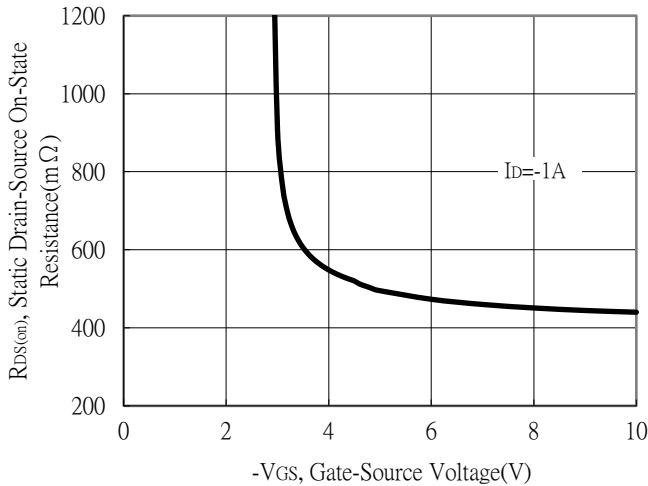
Static Drain-Source On-State resistance vs Drain Current



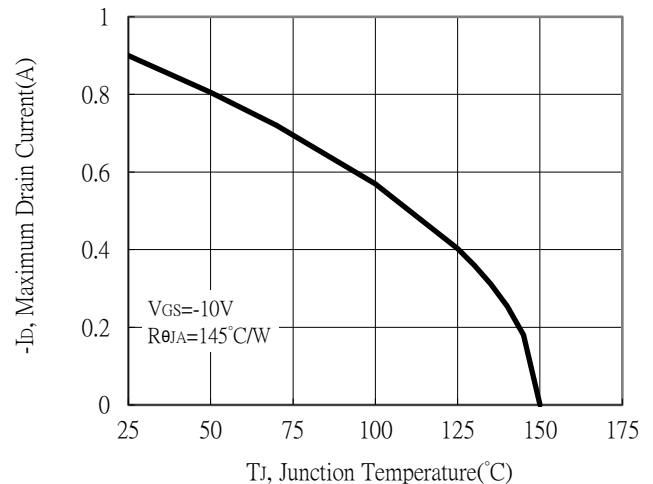
Threshold Voltage vs Junction Temperature



Static Drain-Source On-State Resistance vs Gate-Source Voltage

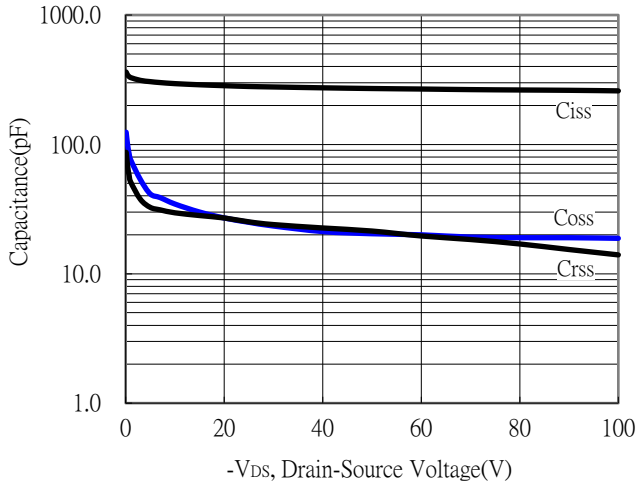


Maximum Drain Current vs Junction Temperature

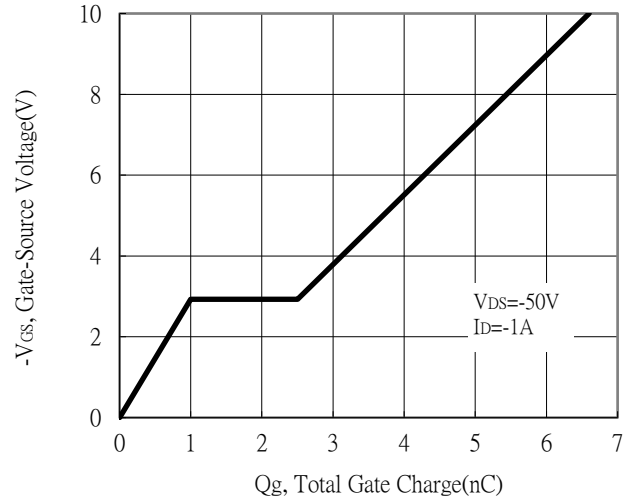


P-Channel Enhancement Mode MOSFET

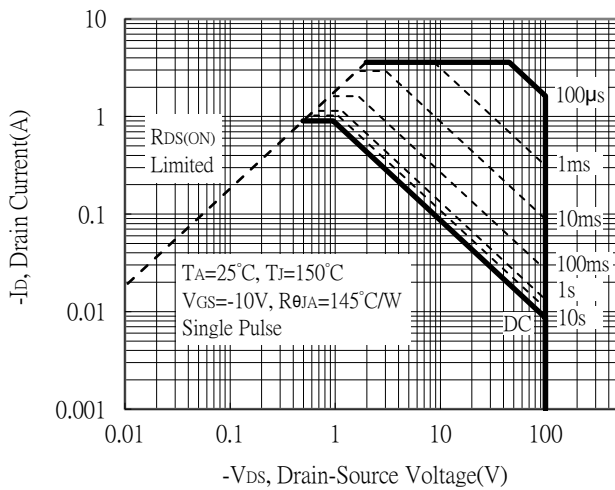
Capacitance vs Drain-to-Source Voltage



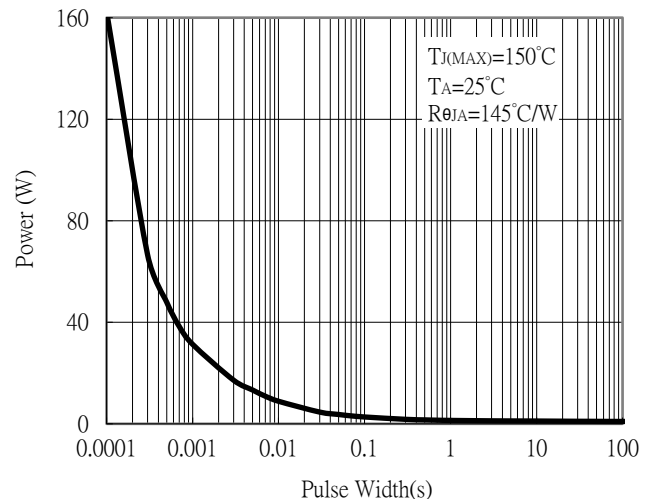
Gate Charge Characteristics



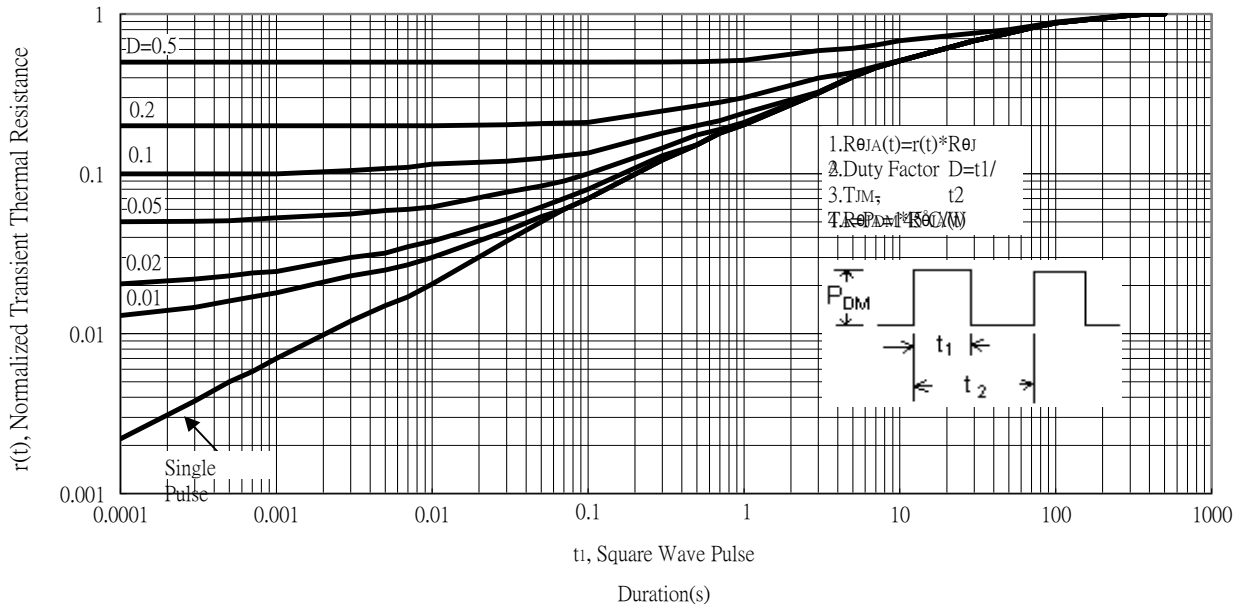
Maximum Safe Operating Area

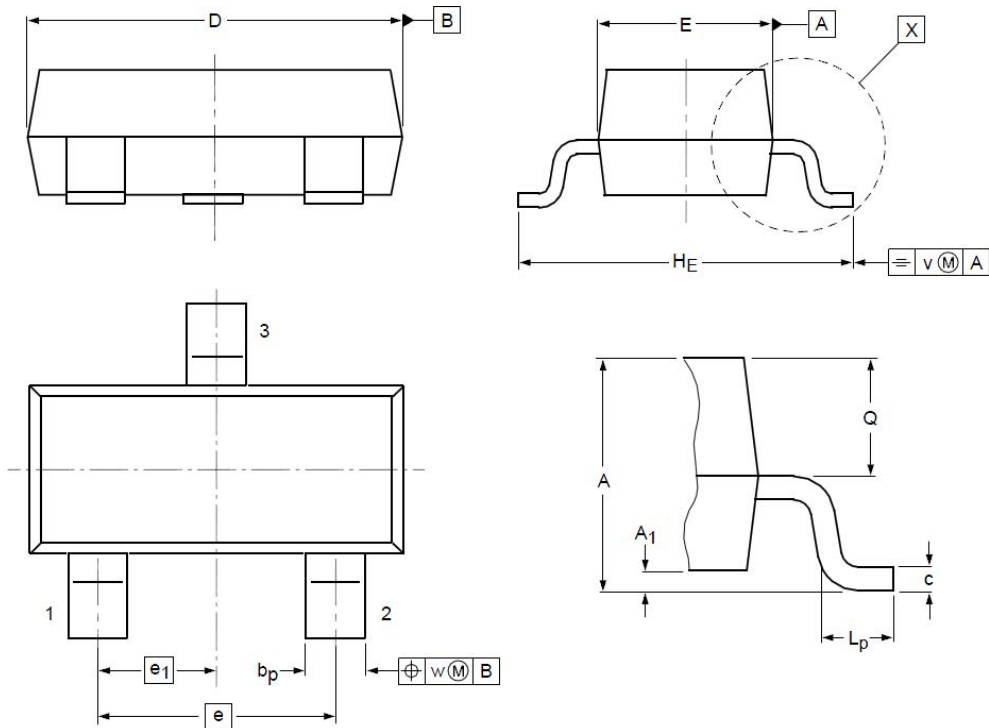


Single Pulse Power Rating, Junction to Ambient



Transient Thermal Response Curves



P-Channel Enhancement Mode MOSFET
SOT23 Package Outline Dimensions


Symbol	Dimensions (unit:mm)			Symbol	Dimensions (unit:mm)		
	Min	Typ	Max		Min	Typ	Max
A	0.90	1.05	1.20	e₁	--	0.95	--
A₁	0.01	0.05	0.10	H_E	2.10	2.40	2.50
b_p	0.38	0.42	0.48	L_p	0.40	0.50	0.60
c	0.09	0.13	0.15	Q	0.45	0.49	0.55
D	2.80	2.92	3.00	V	--	0.20	--
E	1.20	1.33	1.40	W	--	0.10	--
e	--	1.90	--				